


<b>Search Notes</b>  	<b>Application/Control No.</b>  10549506	<b>Applicant(s)/Patent Under Reexamination</b>  ANDERSEN ET AL.
	<b>Examiner</b>  SAMUEL W LIU	<b>Art Unit</b>  1656

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STIC SEQ search for SEQ ID NO:2.	7/8/2009	SWL
WEST search for FVII or FVIIa or VII/VIIa or factor VII or factor VIIa)/mutant or variant/insertion/residue 237.	7/14/2009	SWL
eDAN ad PALm inventr name search, and review (for ODP) applications Nos. 10512754, 10529624, 11021239, 11379658, 11381705, 11381713, 11381717, 1381718, 11424030, 11424035 and 11643535.	7/10/2009	SWL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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